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SP8K2

Switching (30V, 6.0A)

SP8K2

Features

- 1) Low on-resistance.
- 2) Built-in G-S Protection Diode.
- 3) Small and Surface Mount Package (SOP8).

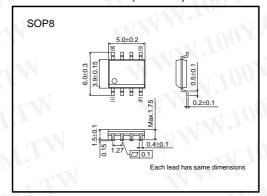
Application

Power switching, DC / DC converter.

Structure

Silicon N-channel MOS FET

External dimensions (Unit : mm)



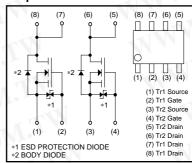
● Absolute maximum ratings (Ta=25°C)

It is the same ratings for the Tr. 1 and Tr. 2.

	•				
Parameter Drain-source voltage		Symbol	Limits	Unit	
		V _{DSS}	30	-V /	
Gate-source voltage		V _{GSS}	20	V	
Drain current	Continuous	ID	±6.0	Α	
	Pulsed	I _{DP}	±24	A *1	
Source current (Body diode)	Continuous	Is	1.6	A A	
	Pulsed	I _{SP}	6.4	A *1	
Total power dissipation	n	PD	2	W *2	
Channel temperature		Tch	150	- C°C	
Storage temperature		Tstg	-55 to +150	°C	
10 10 01 1 1	0.1				

^{*1} Pw≤10μs, Duty cycle≤1% *2 MOUNTED ON A CERAMIC BOARD

●Equivalent circuit



*A protection diode is included between the gate and the source terminals to protect the diode against static electricity when the product is in use. Use the protection circuit when the fixed voltages are exceeded.

●Thermal resistance (Ta=25°C)

Parameter	Symbol	Limits	Unit		
Channel to ambient	Rth (ch-a)	62.5	°C / W *		

*MOUNTED ON A CERAMIC BOARD.

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SP8K2

Transistors

Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	Igss		7-1	10	μΑ	Vgs=20V, Vps=0V
Drain-source breakdown voltage	V _{(BR) DSS}	30	175	-	V	I _D =1mA, V _{GS} =0V
Zero gate voltage drain current	IDSS	_	-	1	μΑ	V _{DS} =30V, V _{GS} =0V
Gate threshold voltage	V _{GS (th)}	1.0	1-1	2.5	V	V _{DS} =10V, I _D =1mA
Out Island	~ 7	(JV	21	30		I _D =6.0A, V _{GS} =10V
Static drain-source on-state resistance	R _{DS (on)}	_	30	42	mΩ	I _D =6.0A, V _{GS} =4.5V
resistance		- 1	33	47	- 41	I _D =6.0A, V _{GS} =4V
Forward transfer admittance	Y _{fs} *	4.0	_	- 1	S	I _D =6.0A, V _{DS} =10V
Input capacitance	Ciss	_	520	NJ.	pF	Vps=10V
Output capacitance	Coss	4	150	_	pF	V _G s=0V
Reverse transfer capacitance	Crss	ĮΣ.	95	\—\(\)	pF	f=1MHz
Turn-on delay time	t _{d (on)} *		9	$D_{F_{A,r}}$	ns	I _D =3A, V _{DD} ≒15V
Rise time	tr *	167	21	_	ns	V _{GS} =10V
Turn-off delay time	t _{d (off)} *	0.5	36		ns	R _L =5Ω
Fall time	t _f *	-20	13	7	ns	$R_{GS}=10\Omega$
Total gate charge	Q _g *		7.2	10.1	nC	V _{DD} ≒15V
Gate-source charge	Q _{gs} *	_	1.8		nC	V _{GS} =5V
Gate-drain charge	Q _{gd} *	-0	2.8	_	nC	I _D =6.0A

●Body diode characteristics (Source-Drain Characteristics) (Ta=25°C)

It is the same characteristics for the Tr. 1 and Tr. 2.

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	V _{SD} *	_	. = (1.2	V	I _S =6.4A, V _{GS} =0V

^{*}Pulsed

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Transistors

Electrical characteristic curves

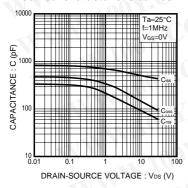


Fig.1 Typical Capacitance vs. Drain-Source Voltage

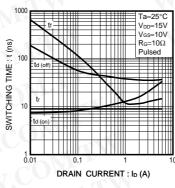


Fig.2 Switching Characteristics

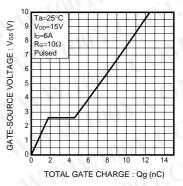


Fig.3 Dynamic Input Characteristics

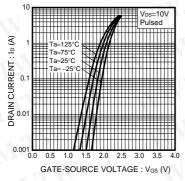


Fig.4 Typical Transfer Characteristics

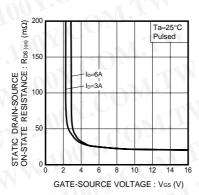


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

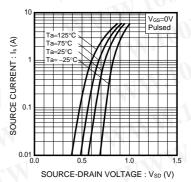


Fig.6 Source Current vs. Source-Drain Voltage

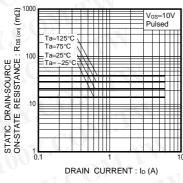


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (I)

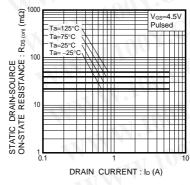


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (II)

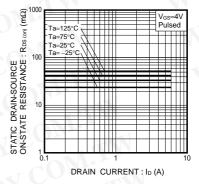


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (III)

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Appendix

Notes

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